 Searcl	h Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/746,921	THORNE ET AL.	
Examiner	Art Unit	
Patricia Leith	1655	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Updated EAST: JPO,EPO,DERWENT,USPATFULL,U SPGPUBS,OCRBACKFILE	7/10/2006	PL
Updated EAST cont	7/13/2006	PL
Updated STN Reg & Indexed Bioscience cluster (76 databases)	7/10/2006	PL
Updated EAST cont	7/21/2006	PL